Model-Implemented Hybrid Fault Injection for Simulink (Tool demonstration)

Mehrdad Moradi

Oct. 22, 2018 MSDL Research day









Cyber-Physical System



Future direction

http://www.real-programmer.com/interesting_things/IEEE%20SpectrumThisCarRunsOnCode.pdf

Why?	Faults and Failures				
What?		Computer systems (e.g., transaction processing [Gray 1990], electronic switching [Cramp et al. 1992])		Larger, controlled systems (e.g., commercial airplanes [Ruegger 1990], telephone network [Kuhn 1997])	
How?		Rank	Proportion of failures	Rank	Proportion of failures
110 vv :	Physical internal faults	3	~ 10 %	2	15 - 20 %
	Physical external faults	3	~ 10 %	2	15 - 20 %
Conclusion	Human-made interaction faults	2	~ 20 %	1	4050 %
	Design faults	1	~ 60 %	2	15 - 20 %

Future direction

Deswarte, Y., Creese, S., Deswarte, Y., Kursawe, K., Laprie, J.C., Powell, D., Randell, B., Riordan, J., Ryan, P., Simmonds, W., Stroud, R., Verissimo, P., Waidner, M., Wespi, A.: Conceptual Model and Architecture of MAFTIA Conceptual Model and Architecture of MAFTIA Departamento de Inform ´ Faculdade de Ci^. (2003).





FARM model:

- 1. the set of Faults to be injected,
- 2. the set of Activations exercised during the experiment,
- 3. the Readouts to define observers of system behavior,
- 4. the Measures dependability properties.
- Fault Injection Techniques and Tools

 J. Arlat, M. Aguera, L. Amat, Y. Crouzet, J.C. Fabre, J.-C. Laprie, E. Martins, D. Powell, Fault Injection for Dependability Validation: A Methodology and some Applications, IEEE Transactions on Software Engineering, Vol. 16, No. 2, February 1990, pp. 166–182

direction

Future

Conclusion





Framework

Generative techniques: Model-Implemented Hybrid Fault Injection by explicit modelling of FARM in Simulink to setup the experiments both for Model-in-the-Loop (MiL) and Hardware-in-the-Loop (HiL)



Why?
What?
How?
Conclusion
Future direction

Conclusion

- The framework automated the FI process
 - MiL to simulation-based fault injection
 - HiL to execution-based fault injection
 - Cover wide variety of fault type
 - Flexible fault injection scenario

Why?
What?
How?
Conclusion
Future direction

Future direction

- Complete FARM model
 - Temporal Logic
- Efficient fault injection
 - Increase fault coverage and speed
- Complex fault injection
- INES and aSET projects

Thank you for your attention



